

Device No.	Output	Max Ratings @ $T_A = 25^\circ\text{C}$					Coupled Characteristics			
		P_D mW	Transistor I_C mA	V_{CE0} V	Diode V_R V	I_F mA	V_{ISO} kV	Min Current Transfer Ratio I_C/I_F %	@ I_F mA	@ V_{CE} V
4N25 ⁽⁴⁾	Trans	250	—	30	3.0	80	2.5	20	10	10
4N26 ⁽⁴⁾	Trans	250	—	30	3.0	80	1.5	20	10	10
4N27 ⁽⁴⁾	Trans	250	—	30	3.0	80	1.5	10	10	10
4N28 ⁽⁴⁾	Trans	250	—	30	3.0	80	0.5	10	10	10
4N29 ⁽⁴⁾	Darlg	250	125	30	3.0	80	2.5	100	10	10
4N30 ⁽⁴⁾	Darlg	250	125	30	3.0	80	1.5	100	10	10
4N31 ⁽⁴⁾	Darlg	250	125	30	3.0	80	1.5	50	10	10
4N32 ⁽⁴⁾	Darlg	250	125	30	3.0	80	2.5	500	10	10
4N33 ⁽⁴⁾	Darlg	250	125	30	3.0	80	1.5	500	10	10
4N35 ⁽⁴⁾	Trans	300	—	30	6.0	60	3.5	100	10	10
4N36 ⁽⁴⁾	Trans	300	—	30	6.0	60	2.5	100	10	10
4N37 ⁽⁴⁾	Trans	300	—	30	6.0	60	1.5	100	10	10

Notes

1. Standard Transistor output
2. High-speed transistor output
guaranteed 2.0 μs max t_r and t_f with 100 Ω R_L
8.0 μs typ at 1 k Ω R_L
3. CTR guaranteed with transistor in saturation
4. JEDEC registered data and conditions
5. CTR typ at 1.0 mA = 40%

Couplers (Cont'd)

Coupled Characteristics		Input Diode Characteristics		Output Transistor Characteristics			Output Darlington Characteristics		Data Sheet Page No.	Device No.
T_r μs Typ	t_f μs Typ	V_F V Max	I_F mA	$V_{CE(sat)}$ V Max	I_C mA @	I_F mA @	I_{CEO} μA Max	V_{CE} V @		
2.5	2.5	1.5	50	0.5	2.0	50			5-47	4N25 ⁽⁴⁾
2.5	2.5	1.5	50	0.5	2.0	50			5-47	4N26 ⁽⁴⁾
2.5	2.5	1.5	50	0.5	2.0	50			5-47	4N27 ⁽⁴⁾
2.5	2.5	1.5	50	0.5	2.0	50			5-47	4N28 ⁽⁴⁾
10	45	1.5	50	1.0	2.0	8.0	0.1	10	5-49	4N29 ⁽⁴⁾
10	45	1.5	50	1.0	2.0	8.0	0.1	10	5-49	4N30 ⁽⁴⁾
10	45	1.5	50	1.2	2.0	8.0	0.1	10	5-49	4N31 ⁽⁴⁾
10	120	1.5	50	1.0	2.0	8.0	0.1	10	5-49	4N32 ⁽⁴⁾
10	120	1.5	50	1.0	2.0	8.0	0.1	10	5-49	4N33 ⁽⁴⁾
8.0	8.0	1.5	10	0.3	0.5	10			5-51	4N35 ⁽⁴⁾
8.0	8.0	1.5	10	0.3	0.5	10			5-51	4N36 ⁽⁴⁾
8.0	8.0	1.5	10	0.3	0.5	10			5-51	4N37 ⁽⁴⁾

Optically-Coupled Darlington Isolator

Optoelectronics Products

4N29, 4N30 4N31, 4N32 4N33

General Description

The 4N29, 4N30, 4N31, 4N32 and 4N33 series of optoisolators has a silicon npn Planar photo-Darlington transistor coupled to a GaAs diode. Each is mounted in a 6-pin plastic DIP package.

High Current Transfer Ratio

1500 V or 2500 V Minimum Isolation

Input-To-Output

$10^{11} \Omega$ Isolation Resistance

Low Coupling Capacitance

Absolute Maximum Ratings

Maximum Temperature and Humidity

Storage Temperature* -55°C to 150°C

Operating Temperature -55°C to 100°C

Pin Temperature

Soldering, 10 s* 260°C

Total Package Power Dissipation
at $T_A = 25^{\circ}\text{C}$

(LED plus Detector)* 250 mW

Derate Linearly from 25°C * $3.3 \text{ mW}/^{\circ}\text{C}$

Input Diode*

I_F Forward dc Current
Continuous* 80 mA

V_R Reverse Voltage 3.0 V

I_{pk} Peak Forward Current
($1 \mu\text{s}$ pulse width, 300 pps) 3.0 A

P_D Power Dissipation at
 $T_A = 25^{\circ}\text{C}$ 150 mW
Derate Linearly from 25°C $2.0 \text{ mW}/^{\circ}\text{C}$

Output Transistor (Darlington)*

V_{CE} Collector-to-Emitter
Voltage 30 V

V_{CB} Collector-to-Base Voltage 50 V

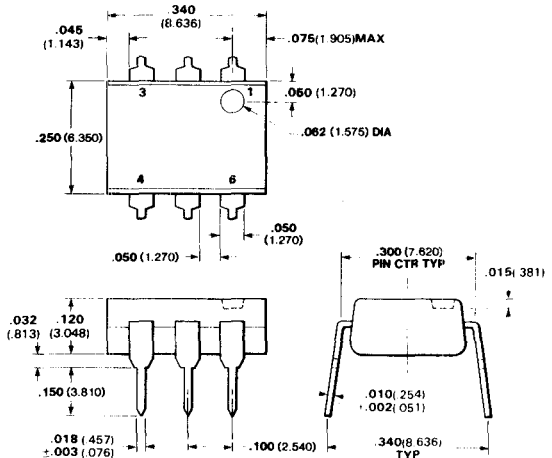
V_{EB} Emitter-to-Base Voltage 8.0 V

V_{EC} Emitter-to-Collector
Voltage 5.0 V

P_D Power Dissipation at
 $T_A = 25^{\circ}\text{C}$ 150 mW
Derate Linearly from 25°C $2.0 \text{ mW}/^{\circ}\text{C}$

*Indicates JEDEC Registered Data

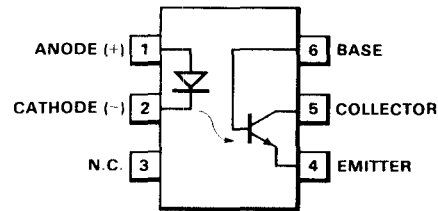
Package Outline



Notes

All dimensions in inches **bold** and millimeters (parentheses)
Tolerance unless specified = ± 0.015 (± 0.381)

Connection Diagram DIP (Top View)



Pin

1	Anode (+)	} Input Diode
2	Cathode (-)	
3	NC	
4	Emitter	} Output npn Phototransistor
5	Collector	
6	Base	

Electrical Characteristics—Input Diode $T_A = 25^{\circ}\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
V_F^*	Forward Voltage		1.2	1.5	V	$I = 50 \text{ mA}$
I_R^*	Reverse Leakage Current		0.05	100	μA	$V_R = 3.0 \text{ V}$
C	Capacitance		150		pF	$V_R = 0 \text{ V}$, $f = 1 \text{ MHz}$

Typical Electrical Characteristics

4N29, 4N30 4N31, 4N32 4N33

Electrical Characteristics—Output Transistor (Darlington) $T_A = 25^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
BV_{CEO}^*	Collector-to-Emitter Breakdown Voltage	30	70		V	$I_C = 100 \mu\text{A}$, $I_B = 0$
BV_{CBO}^*	Collector-to-Base Breakdown Voltage	30			V	$I_C = 100 \mu\text{A}$, $I_E = 0$
BV_{ECO}^*	Emitter-to-Collector Breakdown Voltage	5.0			V	$I_E = 100 \mu\text{A}$, $I_B = 0$
I_{CEO}^*	Collector-to-Emitter Dark Current			100	nA	$V_{CE} = 10 \text{ V}$, Base Open
h_{FE}	Forward Current Gain		2000			$V_{CE} = 5.0 \text{ V}$, $I_C = 500 \mu\text{A}$

Electrical Characteristics—Coupled $T_A = 25^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
I_C^*	Collector Output Current 4N32, 4N33	50			mA	$V_{CE} = 10 \text{ V}$, $I_F = 10 \text{ mA}$
	4N29, 4N30	10			mA	$V_{CE} = 10 \text{ V}$, $I_F = 10 \text{ mA}$
	4N31	5.0			mA	$V_{CE} = 10 \text{ V}$, $I_F = 10 \text{ mA}$
V_{ISO}^*	Isolation Voltage 4N29, 4N32	2500			V	
	4N30, 4N31, 4N33	1500			V	
R_{ISO}^*	Isolation Resistance		10^{11}		Ω	$V = 500 \text{ V}$
$V_{CE(sat)}^*$	Collector-to-Emitter Saturation Voltage 4N31			1.2	V	$I_C = 2.0 \text{ mA}$, $I_F = 8.0 \text{ mA}$
	4N29, 4N30, 4N32, 4N33			1.0	V	$I_C = 2.0 \text{ mA}$, $I_F = 8.0 \text{ mA}$
C_{ISO}	Isolation Capacitance		1.5		pF	$V = 0$, $f = 1.0 \text{ MHz}$
t_{on}	Turn-on Time		10		μs	$I_C = 50 \text{ mA}$, $V_{CC} = 10 \text{ V}$, $R_L = 180 \Omega$, $I_F = 200 \text{ mA}$
t_{off}	Turn-off Time (See Note) 4N29, 4N30, 4N31		20	45	μs	$I_C = 50 \text{ mA}$, $V_{CC} = 10 \text{ V}$, $R_L = 180 \Omega$, $I_F = 200 \text{ mA}$
	4N32, 4N33		60	120	μs	

Note

Turn-on time is defined as the time for the (base collector) current to rise from 10% to 90% of peak value. Turn-off time is defined as the time required for the current to decrease from 90% to 10% of peak value.

*Indicates JEDEC Registered Data.